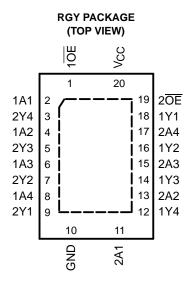


#### FEATURES

- Inputs Are TTL-Voltage Compatible
- 4.5-V to 5.5-V V<sub>CC</sub> Operation
- Typical t<sub>pd</sub> = 5.4 ns at 5 V
- Typical  $V_{OLP}$  (Output Ground Bounce) <0.8 V at  $V_{CC}$  = 5 V,  $T_A$  = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
  >2.3 V at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C
- Supports Mixed-Mode Voltage Operation on All Ports

DB, DGV, DW, NS, OR PW PACKAGE (TOP VIEW)										
10E [ 1A1 [ 2Y4 [ 1A2 [ 2Y3 [ 2Y2 [ 1A4 [ 2Y1 [	1 2 3 4 5 6 7 8 9	20 19 18 17 16 15 14 13 12	V <sub>CC</sub> 2OE 1Y1 2A4 1Y2 2A3 1Y3 2A2 1Y4							
GND [	10	11	2A1							

- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)
  - 200-V Machine Model (A115-A)
  - 1000-V Charged-Device Model (C101)



#### **DESCRIPTION/ORDERING INFORMATION**

This octal buffer/driver is designed specifically to improve both the performance and density of 3-state memory-address drivers, clock drivers, and bus-oriented receivers and transmitters.

The SN74LV244AT is organized as two 4-bit buffers/line drivers with separate output-enable ( $\overline{OE}$ ) inputs. When  $\overline{OE}$  is low, the device passes data from the A inputs to the Y outputs. When  $\overline{OE}$  is high, the outputs are in the high-impedance state.

T <sub>A</sub>	PA	CKAGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING		
	QFN – RGY	QFN – RGY Reel of 1000 SN74LV244ATRGYR				
	SOIC - DW	Tube of 25	SN74LV244ATDW	LV244AT		
SOIC -	50IC - DW	Reel of 2000	SN74LV244ATDWR	LV244A1		
	SOP – NS	Reel of 2000	SN74LV244ATNSR	74LV244AT		
–40°C to 85°C	SSOP – DB	Reel of 2000	SN74LV244ATDBR	LV244AT		
		Tube of 70	SN74LV244ATPW			
	TSSOP – PW	Reel of 2000	SN74LV244ATPWR	LV244AT		
		Reel of 250	SN74LV244ATPWT			
	TVSOP – DGV	Reel of 2000	SN74LV244ATDGVR	LV244AT		

#### ORDERING INFORMATION

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

### SN74LV244AT OCTAL BUFFER/DRIVER WITH 3-STATE OUTPUTS

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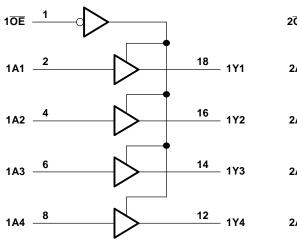
#### **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

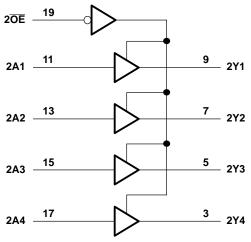
To ensure the high-impedance state during power up or power down,  $\overline{OE}$  shall be tied to V<sub>CC</sub> through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

This device is fully specified for partial-power-down applications using  $I_{off}$ . The  $I_{off}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

#### FUNCTION TABLE (EACH 4-BIT BUFFER/DRIVER)

INP	UTS	OUTPUT
OE	Α	Y
L	Н	Н
L	L	L
н	Х	Z





#### LOGIC DIAGRAM (POSITIVE LOGIC)

## Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	7	V
VI	Input voltage range <sup>(2)</sup>		-0.5	7	V
Vo	Voltage range applied to any output in the	high-impedance or power-off state <sup>(2)</sup>	-0.5	7	V
Vo	Output voltage range applied in the high o	r low state <sup>(2)(3)</sup>	-0.5	V <sub>CC</sub> + 0.5	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-20	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
I <sub>O</sub>	Continuous output current	$V_{O} = 0$ to $V_{CC}$		±35	mA
	Continuous current through $V_{CC}$ or GND			±70	mA
	Input voltage range <sup>(2)</sup> Voltage range applied to any output in the I Output voltage range applied in the high or Input clamp current Output clamp current Continuous output current Continuous current through V <sub>CC</sub> or GND Package thermal impedance	DB package <sup>(4)</sup>		70	
		DGV package <sup>(4)</sup>		92	
0		DW package <sup>(4)</sup>		58	0000
$\theta_{JA}$	Package thermal impedance	NS package <sup>(4)</sup>		60	°C/W
		PW package <sup>(4)</sup>		83	
		RGY package <sup>(5)</sup>		37	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

(2) The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.

(3) This value is limited to 5.5 V maximum.

(4) The package thermal impedance is calculated in accordance with JESD 51-7

(5) The package thermal impedance is calculated in accordance with JESD 51-5.

#### **Recommended Operating Conditions**<sup>(1)</sup>

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage		4.5	5.5	V
V <sub>IH</sub>	High-level input voltage	$V_{CC}$ = 4.5 V to 5.5 V	2		V
VIL	Low-level input voltage	$V_{CC}$ = 4.5 V to 5.5 V		0.8	V
VI	Input voltage		0	5.5	V
V		High or low state	0	$V_{CC}$	V
Vo	Output voltage	3-state	0	5.5	v
I <sub>OH</sub>	High-level output current	$V_{CC}$ = 4.5 V to 5.5 V		-16	mA
I <sub>OL</sub>	Low-level output current	$V_{CC}$ = 4.5 V to 5.5 V		16	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	$V_{CC}$ = 4.5 V to 5.5 V		20	ns/V
T <sub>A</sub>	Operating free-air temperature		-40	85	°C

 All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

### SN74LV244AT OCTAL BUFFER/DRIVER WITH 3-STATE OUTPUTS

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#### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	METER TEST CONDITIONS		т,	₄ = 25°C	;	T <sub>A</sub> = to 85	UNIT	
			MIN	TYP	MAX	MIN	MAX	
V	I <sub>OH</sub> = -50 μA	4.5 V	4.4	4.5		4.4		V
V <sub>OH</sub>	I <sub>OH</sub> = -16 mA	4.5 V	3.8			3.8		v
V	$I_{OL} = 50 \ \mu A$	4.5 V		0	0.1		0.1	V
V <sub>OL</sub>	I <sub>OL</sub> = 16 mA	4.5 V			0.55		0.55	v
l <sub>l</sub>	$V_1 = 5.5 \text{ V or GND}$	0 to 5.5 V			±0.1		±1	μΑ
I <sub>OZ</sub>	$V_{O} = V_{CC}$ or GND	5.5 V			±0.25		±2.5	μΑ
I <sub>CC</sub>	$V_{I} = V_{CC} \text{ or } GND,  I_{O} = 0$	5.5 V			2		20	μΑ
$\Delta I_{CC}^{(1)}$	One input at 3.4 V, Other inputs at $V_{CC}$ or GND	5.5 V			1.35		1.5	mA
I <sub>off</sub>	$V_{I}$ or $V_{O} = 0$ to 5.5 V	0			0.5		5	μA
Ci	$V_{I} = V_{CC} \text{ or } GND$			4.5				pF

(1) This is the increase in supply current for each input at one of the specified TTL voltage levels, rather than 0 V or V<sub>CC</sub>.

#### **Switching Characteristics**

over recommended operating free-air temperature range, V<sub>CC</sub> = 5 V  $\pm$  0.5 V (unless otherwise noted) (see Figure 1)

	FROM	то	LOAD	Τ,	ג = 25°0	:	MAINI		
PARAMETER	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	UNIT
t <sub>PLH</sub>	A or B	B or A	C <sub>1</sub> = 15 pF	2.6	5/4	7.4	1	8.5	ns
t <sub>PHL</sub>	AUB	BUIA	$C_L = 10 \text{ pr}$	2.4	5.4	7.4	1	8.5	115
t <sub>PZH</sub>	OE	A or B	С <sub>L</sub> = 15 рF	2.2	7.7	10.4	1	12	ns
t <sub>PZL</sub>	OL	A OF B	$O_L = 15 \text{ pr}$	2.7	7.7	10.4	1	12	115
t <sub>PHZ</sub>	OE	A or B	С <sub>L</sub> = 15 рF	2.2	3.9	7.7	1	8	ns
t <sub>PLZ</sub>	OL		0[ = 10 pi	2.5	3.9	7.7	1	8	113
t <sub>PLH</sub>	A or B	B or A	С <sub>L</sub> = 50 рF	4	5.9	8.9	1	9.5	ns
t <sub>PHL</sub>	AUB	BUIA	CL = 50 pr	4.7	5.9	8.9	1	9.5	115
t <sub>PZH</sub>	OE	A or B	C <sub>L</sub> = 50 pF	3.9	8.2	11.4	1	13	20
t <sub>PZL</sub>	UE	AUB	CL = 50 pr	4.9	8.2	11.4	1	13	ns
t <sub>PHZ</sub>	OE	A or B	C <sub>L</sub> = 50 pF	3.3	8.8	11.4	1	13	ns
t <sub>PLZ</sub>	UE	AUB	$O_L = 50 \text{ pr}$	3.2	8.8	11.4	1	13	113
t <sub>sk(o)</sub>			C <sub>L</sub> = 50 pF			1		1	ns

#### Noise Characteristics<sup>(1)</sup>

 $V_{CC} = 5 \text{ V}, \text{ C}_{L} = 50 \text{ pF}$ 

	PARAMETER	Т	<sub>A</sub> = 25°	с С	UNIT
	PARAMETER	<b>MIN TYP</b> 0.8	TYP	MAX	UNIT
V <sub>OL(P)</sub>	Quiet output, maximum dynamic V <sub>OL</sub>		0.8	1	V
V <sub>OL(V)</sub>	Quiet output, minimum dynamic V <sub>OL</sub>		-0.8	-1	V
V <sub>OH(V)</sub>	Quiet output, minimum dynamic V <sub>OH</sub>		4		V
V <sub>IH(D)</sub>	High-level dynamic input voltage	2			V
V <sub>IL(D)</sub>	Low-level dynamic input voltage			0.8	V

(1) Characteristics are for surface-mount packages only.



### **Operating Characteristics**

 $V_{\rm CC} = 5 \text{ V}, \text{ T}_{\rm A} = 25^{\circ} \text{C}$ 

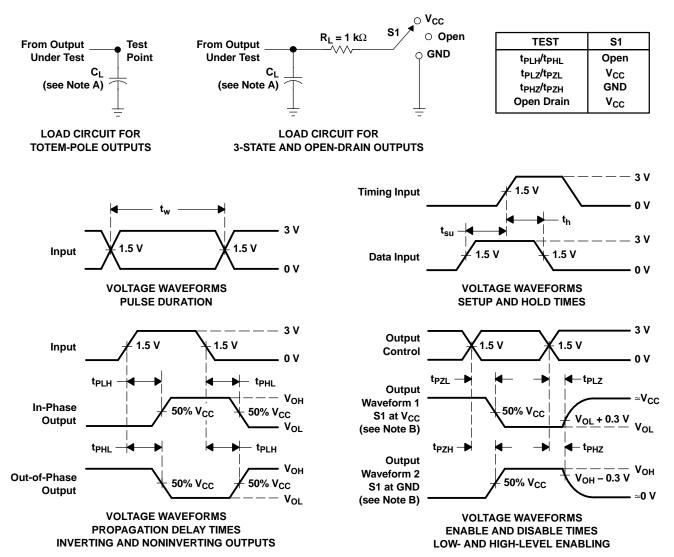
	PARAMETER	TEST C	TYP	UNIT		
$C_{pd}$	Power dissipation capacitance	Outputs enabled	$C_{L} = 50 \text{ pF},$	f = 10 MHz	8	pF

#### SN74LV244AT OCTAL BUFFER/DRIVER WITH 3-STATE OUTPUTS

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#### PARAMETER MEASUREMENT INFORMATION



NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
  Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>Q</sub> = 50  $\Omega$ , t<sub>f</sub>  $\leq$  3 ns, t<sub>f</sub>  $\leq$  3 ns.
- D. The outputs are measured one at a time, with one input transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- G.  $t_{PHL}$  and  $t_{PLH}$  are the same as  $t_{pd}$ .
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuits and Voltage Waveforms



#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
	(1)		Diamig		<u> </u>	(2)	(6)	(3)		(4/3)	
SN74LV244ATDWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LV244AT	Samples
SN74LV244ATNSR	ACTIVE	SO	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	74LV244AT	Samples
SN74LV244ATPWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LV244AT	Samples
SN74LV244ATRGYR	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	VV244	Samples
SN74LV244ATRGYRG4	ACTIVE	VQFN	RGY	20	3000	RoHS & Green	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	VV244	Samples

<sup>(1)</sup> The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

<sup>(2)</sup> RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

<sup>(5)</sup> Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

<sup>(6)</sup> Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.



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## PACKAGE OPTION ADDENDUM

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\*All dimensions are nominal

STRUMENTS

#### TAPE AND REEL INFORMATION





#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LV244ATDWR	SOIC	DW	20	2000	330.0	24.4	10.8	13.3	2.7	12.0	24.0	Q1
SN74LV244ATNSR	SO	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74LV244ATPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
SN74LV244ATRGYR	VQFN	RGY	20	3000	330.0	12.4	3.8	4.8	1.6	8.0	12.0	Q1



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## PACKAGE MATERIALS INFORMATION

16-Apr-2024



\*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LV244ATDWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74LV244ATNSR	SO	NS	20	2000	367.0	367.0	45.0
SN74LV244ATPWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74LV244ATRGYR	VQFN	RGY	20	3000	356.0	356.0	35.0

#### MECHANICAL DATA

#### PLASTIC SMALL-OUTLINE PACKAGE

#### 0,51 0,35 ⊕0,25⊛ 1,27 8 14 0,15 NOM 5,60 8,20 5,00 7,40 $\bigcirc$ Gage Plane ₽ 0,25 7 1 1,05 0,55 0-10 Δ 0,15 0,05 Seating Plane — 2,00 MAX 0,10PINS \*\* 14 16 20 24 DIM 10,50 10,50 12,90 15,30 A MAX A MIN 9,90 9,90 12,30 14,70 4040062/C 03/03

NOTES: A. All linear dimensions are in millimeters.

NS (R-PDSO-G\*\*)

**14-PINS SHOWN** 

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



## **GENERIC PACKAGE VIEW**

### VQFN - 1 mm max height

PLASTIC QUAD FGLATPACK - NO LEAD

3.5 x 4.5, 0.5 mm pitch

**RGY 20** 

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





4225264/A

# **RGY0020A**



## **PACKAGE OUTLINE**

### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice.
- 3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.



# **RGY0020A**

# **EXAMPLE BOARD LAYOUT**

### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

4. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).

5. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



# **RGY0020A**

# **EXAMPLE STENCIL DESIGN**

### VQFN - 1 mm max height

PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

6. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



# **DW0020A**



## **PACKAGE OUTLINE**

### SOIC - 2.65 mm max height

SOIC



NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



## DW0020A

# **EXAMPLE BOARD LAYOUT**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## DW0020A

# **EXAMPLE STENCIL DESIGN**

### SOIC - 2.65 mm max height

SOIC



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



# **PW0020A**



## **PACKAGE OUTLINE**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M. 2. This drawing is subject to change without notice. 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



## PW0020A

# **EXAMPLE BOARD LAYOUT**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



## PW0020A

# **EXAMPLE STENCIL DESIGN**

### TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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